TEST PHOTOGRAPHS 17.

See following Attached Pages for setup photographs.

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Figure 17-1 Ear Reference Point HAC Phantom Alignment

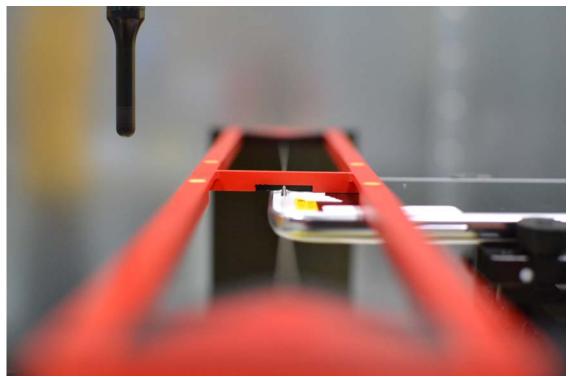


Figure 17-2 HAC Phantom Plane Alignment

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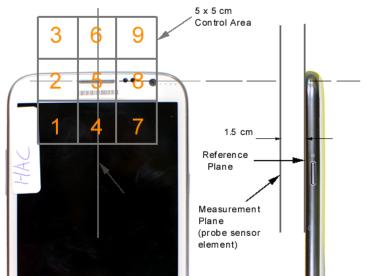


Figure 17-3 5x5 Scan grid above WD





Figure 17-4 E-Field WD Scan overlay

Figure 17-5 H-Field WD Scan overlay

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